

 <p>SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT BY APPLICANT PTO-1449</p>	DOCKET NO. 52433/803	SERIAL NO. 10/540,418
	APPLICANT Okamoto et al.	
	FILING DATE June 24, 2005	GROUP 3725 1793

U. S. PATENT DOCUMENTS

EXAMINER INITIAL	PATENT/PUBLICATION NUMBER	PATENT/PUBLICATION DATE	NAME	CLASS	SUBCLASS	FILING DATE

FOREIGN PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
						Yes	No
/D.Y./	CN 1251140A	July 19, 2000	China	_____	_____		X
/D.Y./	JP 2002-180190	June 26, 2002	Japan	_____	_____	Abstract	

OTHER DOCUMENTS

EXAMINER INITIAL	AUTHOR, TITLE, DATE, PERTINENT PAGES, ETC.

EXAMINER	/Deborah Yee/	DATE CONSIDERED 10/18/2007
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EXAMINER INITIAL	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
						Yes	No
/D.Y./	EP 0 881 308 A1	December 02, 1998	Europe				
	EP 1 001 041 A1	May 17, 2000	Europe				
	EP 1 154 028 A1	November 14, 2001	Europe				
	JP 07252592	October 03, 1995	Japan			Abstract	
↓	WO 03/010351	February 06, 2003	PCT				

OTHER DOCUMENTS

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U. S. PATENT DOCUMENTS

EXAMINER INITIAL	PATENT/PUBLICATION NUMBER	PATENT/PUBLICATION DATE	NAME	CLASS	SUBCLASS	FILING DATE
/D.Y./	5,470,529	November 28, 1995	Nomura et al.			

FOREIGN PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
						Yes	No
	0 969 112	January 3, 2000	EP				
	0 974 677	January 26, 2000	EP				
	11 323480	November 26, 1999	JP			Abstract	
	1 213 368	June 12, 2002	EP				

OTHER DOCUMENTS

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INFORMATION DISCLOSURE STATEMENT BY APPLICANT PTO-1449	DOCKET NO. 52433/803	10/540418 <small>SEARCHING</small> Not Yet Assigned
	APPLICANT Riki OKAMOTO et al.	
	FILING DATE Herewith	GROUP 1793 Not Yet Assigned

U. S. PATENT DOCUMENTS

EXAMINER INITIAL	PATENT/PUBLICATION NUMBER	PATENT/PUBLICATION DATE	NAME	CLASS	SUBCLASS	FILING DATE

FOREIGN PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
						Yes	No
/D.Y./	EP 1201780 ✓	May 2, 2002	Europe	_____	_____	English Document	
	JP 2000-63955 ✓	February 29, 2000	Japan	_____	_____	Abstract	
	EP 1149925 ✓	October 31, 2001	Europe	_____	_____	English Document	
	JP 2001-32041 ✓	February 6, 2001	Japan	_____	_____	Abstract	
	JP 2000-144261 ✓	May 26, 2000	Japan	_____	_____	Abstract	
	JP 5-112846 ✓	May 7, 1993	Japan	_____	_____	Abstract	
	JP 2003-342684 ✓	December 3, 2003	Japan	_____	_____	Abstract	
	JP 2004-27249 ✓	January 29, 2004	Japan	_____	_____	Abstract	
	JP 2001-303186 ✓	October 31, 2001	Japan	_____	_____	Abstract	

OTHER DOCUMENTS

EXAMINER INITIAL		AUTHOR, TITLE, DATE, PERTINENT PAGES, ETC.

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